

**Search Notes**

Application/Control No.

10/696,431

Examiner

Paul D. Kim

Applicant(s)/Patent under  
Reexamination

HAN ET AL.

Art Unit

3729

**SEARCHED**

Class	Subclass	Date	Examiner
29	603.07 603.11 603.13- 603.16	11/15/2006	PK
	603.18		
360	235.2		
	234.7		
	319 320		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/PGPub	11/15/2006	pk
Updated Text Search EAST/PGPub	11/20/2006	PK
Updated Text Search EAST/PGPub	4/17/2007	PK